

Shenzhen Anbotek Compliance Laboratory Limited
TEST REPORT

Report No.....: R011411399S

Client.....: Key Technology (China) Limited

Address.....: B702, Building 1, Tianan Cyber Park, Huang Ge North Rd, Longcheng
Subdistrict, Long Gang District, ShenZhen, Guang Dong, P.R.China

Manufacturer.....: Key Technology (China) Limited

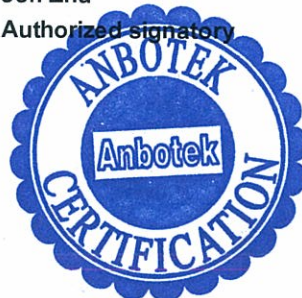
Address.....: B702, Building 1, Tianan Cyber Park, Huang Ge North Rd, Longcheng
Subdistrict, Long Gang District, ShenZhen, Guang Dong, P.R.China

Written by : Andy Shen

Inspected by : Terry Tian

Approved by : Jeff Zhu

Jeff Zhu
Authorized signatory



Date of Received Sample : Nov. 21, 2014

Date(s) of Test : Nov. 21, 2014 to Nov. 28, 2014

Shenzhen Anbotek Compliance Laboratory Limited
TEST REPORT

Sample name	Special Professional Ruggedized Rubber Keyboard		
Model/type	K-TEK-M275TP-FN		
Inspection unit	Key Technology (China) Limited	Trademark	IKB-MKB
Manufacturer	Key Technology (China) Limited	Inspection Category	Commissioned the inspection
Quantity	2 pcs	Sample grade, status	— / Intact
sample date	Nov. 21, 2014	Original number or production date	—
Test based on	IEC 60068-2-1:2007 , IEC 60068-2-2 : 2007	Test items	High and low temperature test
main instruments used	Heat chamber	Ambient temperature	25.0℃
Conclusions of the examination	The samples were passed the Principal technical requirements		
Remark	This report is only responsible for the sample.		

Test Item: High and low temperature test

1. The Equipment lists:

Name	Model	Manufacturer	Serial No.	Valid Date to
Heat chamber	GDS-1000	Guangzhou Gongwen Experimental Equipment Co., Ltd.	SE-121	Apr.15, 2015

2. Environmental Conditions: $25 \pm 3^{\circ}\text{C}$, $55 \pm 20\%$ RH

3. Sample Quantity: 2 pcs

4. Reference Standard: According to the client requirements.

- 1). The Heat chamber temperature within six hours increased from room temperature to 80°C , keeping 80°C for 15 hours;
- 2). Within 12 hours reduced from 80°C to -40°C ;
- 3). Keeping -40°C , test 15 hours; (“1) to 3)” as one cycle)

Test Result:

After the test, the samples function tests:

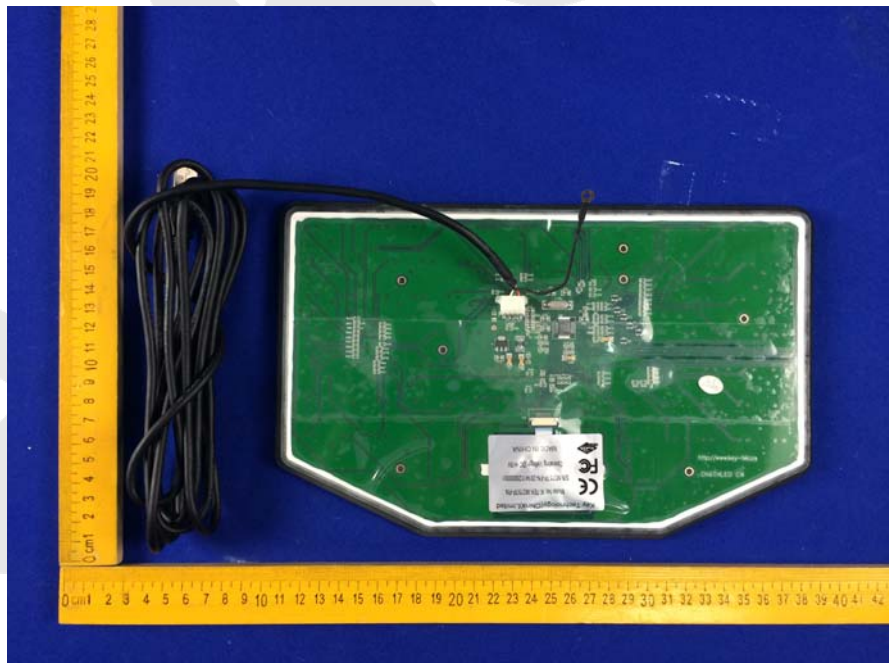
The samples were normal operation, No abnormal appearance.

The sample photo attached as below.

Testing :



After test :



DECLARATION

- 1 · Reference documents for the testing: IEC 60068-2-1:2007 · IEC 60068-2-2 : 2007
- 2 · Test place Lab: Shenzhen Anbotek Compliance Laboratory Limited
1/F., Building 1, SEC Industrial Park, No.0409 Qianhai Road, Nanshan District,
Shenzhen, Guangdong, China
- 3 · This report shall not be revised and deleted.
- 4 · The results only related to the items tested.
- 5 · This report shall not be published as advertisement without the approval of ANBOTEK.
- 6 · This report shall not be copied partly without the written approval of ANBOTEK.

*****End of report*****